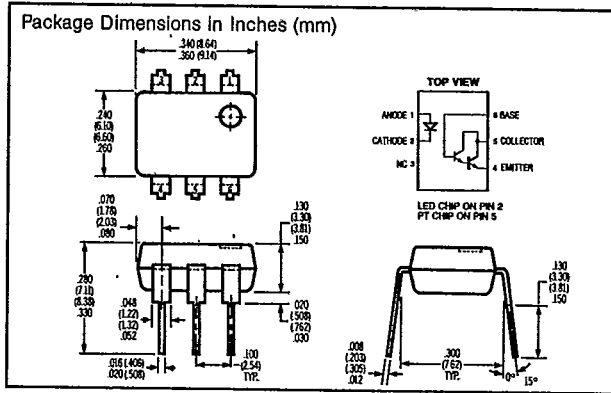
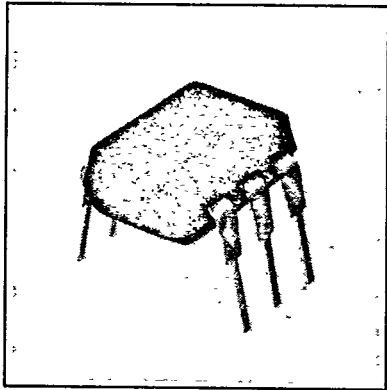


T-41-85



**FEATURES**

- 7500 Volt Withstand Test Voltage
- 0.5 pF Coupling Capacitance
- CTR Minimum at  $I_F = 1$  mA:
  - H11B1 500%
  - H11B2 200%
  - H11B3 100%
- Underwriters Lab Approval #E52744

**DESCRIPTION**

The H11B1/H11B2/H11B3 are industry standard optocouplers, consisting of a GaAs infrared LED and a silicon photodarlington transistor. These optocouplers are constructed with a high voltage insulation, double molded packaging process which offers 7.5 KV withstand test capability.

**Maximum Ratings**

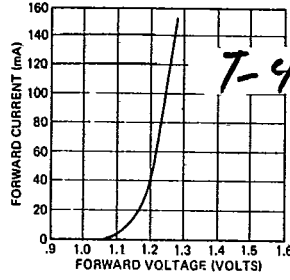
Gallium Arsenide LED	
Power Dissipation at 25°C	100 mW
Derate Linearly from 25°C	1.33 mW/°C
Continuous Forward Current	.60 mA
Reverse Voltage	.3 V
Detector Silicon Phototransistor	
Power Dissipation at 25°C	150 mW
Derate Linearly from 25°C	2.0 mW/°C
Collector-Emitter Breakdown	.25 V
Emitter-Collector Breakdown	.7 V
Collector-Base Breakdown	.30 V
Collector-Current (Continuous)	100 mA
Package	
Total Package Dissipation at 25°C (LED plus Detector)	260 mW
Derate Linearly from 25°C	3.5 mW/°C
Storage Temperature	-55 to +150°C
Operating Temperature	-55 to +100°C
Lead Soldering Time at 260°C	10 sec

**Electrical Characteristics (T<sub>amb</sub> = 25°C)**

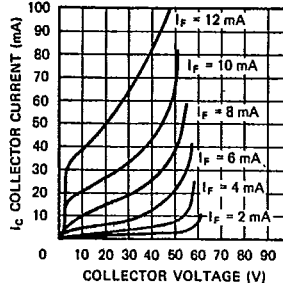
	Min	Typ	Max	Unit	Conditions
<b>Gallium Arsenide LED</b>					
Forward Voltage					
H11B1, B2	1.1	1.5		V	I <sub>F</sub> = 10 mA
H11B3	1.1	1.5		V	I <sub>F</sub> = 50 mA
Reverse Current			10	μA	V <sub>R</sub> = 3 V
Junction Capacitance	50			pF	V <sub>R</sub> = 0 V, f = 1 MHz
<b>Phototransistor Detector</b>					
BV <sub>CEO</sub>	25			V	I <sub>C</sub> = 1.0 mA, I <sub>F</sub> = 0 mA
BV <sub>EBO</sub>	7			V	I <sub>E</sub> = 100 μA, I <sub>F</sub> = 0 mA
BV <sub>CBO</sub>	30			V	I <sub>C</sub> = 100 μA, I <sub>F</sub> = 0 mA
I <sub>CEO</sub>			100	nA	V <sub>CE</sub> = 10 V, I <sub>F</sub> = 0 mA
<b>Coupled Characteristics</b>					
V <sub>CE(sat)</sub>		1.0		V	I <sub>F</sub> = 1 mA, I <sub>C</sub> = 1 mA
<b>DC Current Transfer Ratio</b>					
H11B1	500			%	V <sub>CE</sub> = 5 V, I <sub>F</sub> = 1 mA
H11B2	200			%	V <sub>CE</sub> = 5 V, I <sub>F</sub> = 1 mA
H11B3	100			%	V <sub>CE</sub> = 5 V, I <sub>F</sub> = 1 mA
Capacitance Input to Output		0.5		pF	
Withstand Test Voltage	7500			VDC	t = 1 sec
	5300			VAC <sub>RMS</sub>	t = 1 sec
<b>Resistance Input to Output</b>					
Switching Times		100		μs	R <sub>E</sub> = 100 Ω, V <sub>CE</sub> = 10 V, I <sub>C</sub> = 10 mA
t <sub>on</sub>	125			μs	
t <sub>off</sub>	100			μs	

**TYPICAL OPTOELECTRONIC CHARACTERISTIC CURVES**

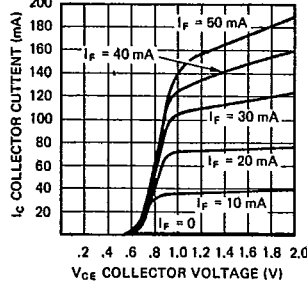
**GaAs EMITTER:  
FORWARD CURRENT - VOLTAGE CHARACTERISTICS**



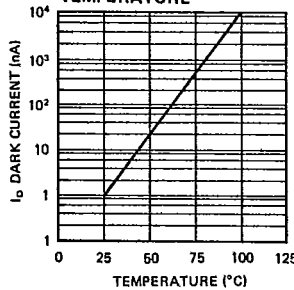
**DARLINGTON TRANSISTOR CURRENT VS VOLTAGE**



**DARLINGTON TRANSISTOR OUTPUT CURRENT VS VOLTAGE**



**DARK CURRENT VS TEMPERATURE**



H11B1/H11B2/H11B3